

BUL903EDFP

HIGH VOLTAGE FAST-SWITCHING NPN POWER TRANSISTOR

- INTEGRATED ANTISATURATION AND PROTECTION NETWORK
- INTEGRATED ANTIPARALLEL COLLECTOR EMITTER DIODE
- HIGH VOLTAGE CAPABILITY
- LOW SPREAD OF DYNAMIC PARAMETERS
- MINIMUM LOT-TO-LOT SPREAD FOR RELIABLE OPERATION
- VERY HIGH SWITCHING SPEED
- ARCING TEST SELF PROTECTED
- FULLY INSULATED PACKAGE (U.L. COMPLIANT) FOR EASY MOUNTING

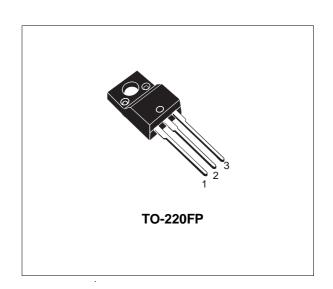


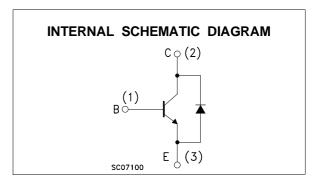
 FOUR LAMP ELECTRONIC BALLAST FOR 120 V MAINS IN PUSH-PULL CONFIGURATION



The BUL903EDFP is manufactured using high voltage Multi Epitaxial Planar technology for high switching speeds and high voltage capability.

The device has been designed to operate without baker clamp and transil protection. This enables saving from 2 up to 10 components in the application.





ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit	
V _{CES}	Collector-Emitter Voltage (V _{BE} = 0)	900	V	
V_{CEO}	Collector-Emitter Voltage (I _B = 0) 400		V	
V_{EBO}	Emitter-Base Voltage (I _C = 0) 7		V	
Ic	Collector Current	5	A	
I _{CM}	Collector Peak Current (t _p <5 ms)	8	A	
lΒ	Base Current	2	A	
I_{BM}	Base Peak Current (t _p <5 ms)	4	Α	
P _{tot}	Total Dissipation at Tc = 25 °C	35	W	
V _{isol}	V _{isol} Insulation Withstand Voltage (RMS) from All Three Leads to Exernal Heatsink		V	
T _{stg}	Storage Temperature	-65 to 150	°C	
Tj	Max. Operating Junction Temperature	150	°C	

September 2003 1/7

THERMAL DATA

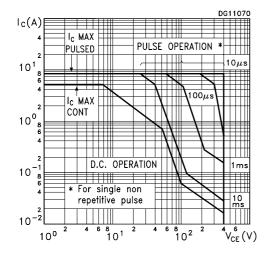
R _{thj-case}	Thermal Resistance Junction-Case	Max	3.57	°C/W
$R_{thj-amb}$	Thermal Resistance Junction-Ambient	Max	62.5	°C/W

ELECTRICAL CHARACTERISTICS (T_{case} = 25 °C unless otherwise specified)

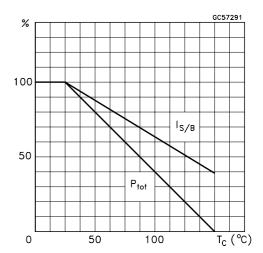
Symbol	Parameter	Test	Test Conditions Min. T		Тур.	Max.	Unit
I _{CES}	Collector Cut-off Current (V _{BE} = 0)	V _{CE} = 900 V				100	μΑ
I _{EBO}	Emitter Cut-off Current (I _C = 0)	V _{EB} = 7 V				100	μΑ
V _{(BR)CES}	Collector-Emitter Breakdown Voltage (V _{BE} = 0)	I _C = 100 μA		900			V
V _{CEO(sus)*}	Collector-Emitter Sustaining Voltage (I _B = 0)	I _C = 10 mA	L = 25 mH	400			V
V _{CE(sat)} *	Collector-Emitter Saturation Voltage	I _C = 0.5 A I _C = 1 A I _C = 2 A	$I_B = 50 \text{ mA}$ $I_B = 0.15 \text{ A}$ $I_B = 0.4 \text{ A}$			0.5 1 1.5	V V V
V _{BE(sat)} *	Base-Emitter Saturation Voltage	$I_{C} = 0.5 A$ $I_{C} = 1 A$ $I_{C} = 2 A$	$I_B = 50 \text{ mA}$ $I_B = 0.15 \text{ A}$ $I_B = 0.4 \text{ A}$			1 1.1 1.2	< < <
h _{FE} *	DC Current Gain	-	V _{CE} = 5 V V _{CE} = 5 V V _{CE} = 5 V V _{CE} = 5 V	20 40 28 8		70 60 16	
t _d t _r t _s	RESISTIVE LOAD Delay Time Rise Time Storage Time Fall Time	$V_{CC} = 125 \text{ V}$ $I_{B1} = 50 \text{ mA}$ $t_p = 300 \mu\text{s}$ (see figure 1)	$I_C = 0.7 \text{ A}$ $I_{B2} = 0.4 \text{ A}$			0.2 1 0.8 0.25	μs μs μs μs
Ear	Repetitive Avalanche Energy	$V_{CC} = 50V$ $V_{BE} = -5 V$ (see figure 2)	C = 1.8 nF L = 2 mH	6			mJ
V _F	Parallel Diode Forward Voltage	I _F = 2 A				1.2	V

^{*} Pulsed: Pulse duration = 300 μs, duty cycle 1.5 %

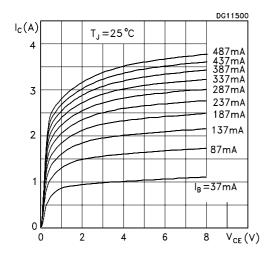
Safe Operating Area



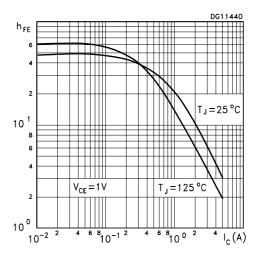
Derating Curve



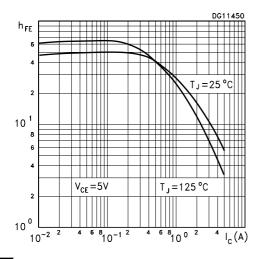
Output Characteristics



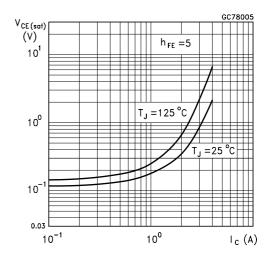
DC Current Gain



DC Current Gain



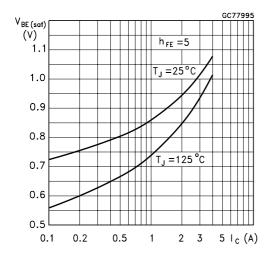
Collector Emitter Saturation Voltage



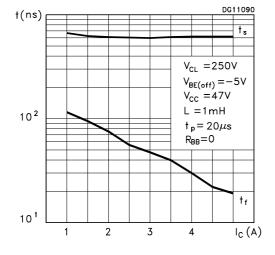
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BUL903EDFP

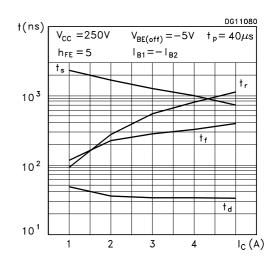
Base Emitter Saturation Voltage



Switching Times Inductive Load



Switching Times Resistive Load



Reverse Biased SOA

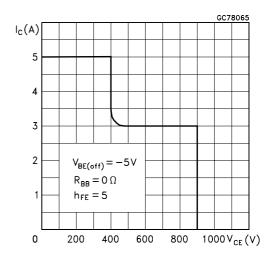


Figure 1: Resistive Load Switching Test Circuit

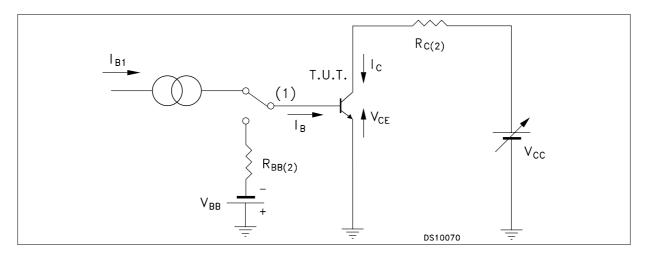


Figure 2 : Energy Rating Test Circuit

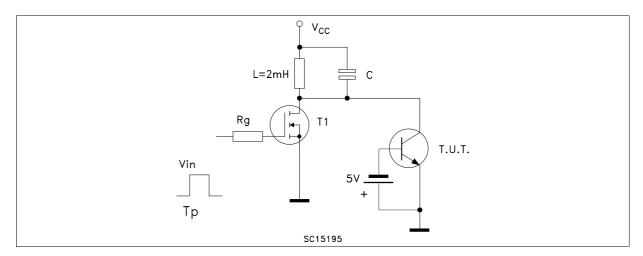
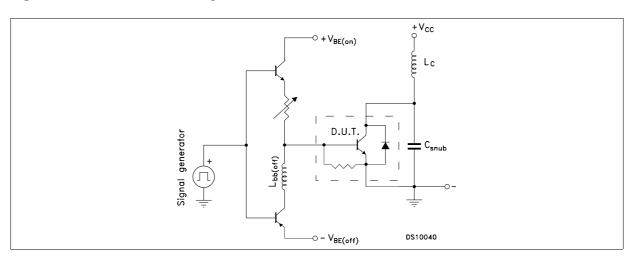
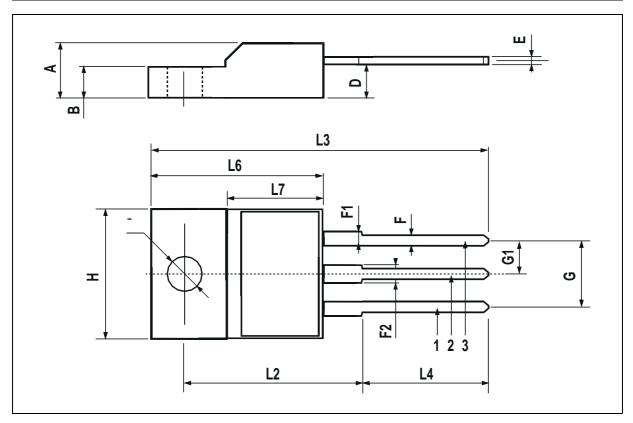


Figure 3: Inductive Load Switching Test Circuit



TO-220FP MECHANICAL DATA

DIM.		mm			inch	
DIIVI.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А	4.4		4.6	0.173		0.181
В	2.5		2.7	0.098		0.106
D	2.5		2.75	0.098		0.108
E	0.45		0.7	0.017		0.027
F	0.75		1	0.030		0.039
F1	1.15		1.7	0.045		0.067
F2	1.15		1.7	0.045		0.067
G	4.95		5.2	0.195		0.204
G1	2.4		2.7	0.094		0.106
Н	10		10.4	0.393		0.409
L2		16			0.630	
L3	28.6		30.6	1.126		1.204
L4	9.8		10.6	0.385		0.417
L6	15.9		16.4	0.626		0.645
L7	9		9.3	0.354		0.366
Ø	3		3.2	0.118		0.126



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